INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 1 of 1 (use as many sheets as necessary)

Complete if Known Application Number Filing Date June 20, 2003 First Named Inventor David A. Hayner et al. Group Art Unit Examiner Name Attorney Docket Number 1280.SC12755TS

U.S. PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS							
Examiner Initials *	Cite No.1	U.S. Patent Document Number Kind Code 2 (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
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PUBLICATIONS

		. 022.071.101.0		
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	AN	Maarten Steinbuch, et al., "Robust Control of a Compact Disc Player," Proceedings of the 31st Conference on Decision and Control, Tucson, AZ, p. 2596-2600.	12/1992 •-	
	AO	Tetsuo Semba, et al., "Interactions between Servo Loops of an Optical Disk Drive," Jpn. J. Appl. Phys., Vol. 36, Part 1, No. 1B, pp. 557-561	01/1997	
	AP	Ting-Jen Yeh, et al., "Modeling and Identification of OPTO-Mechanical Coupling and Backlash Nonlinearity in Optical Disk Drives," IEEE Transactions on Consumer Electronics, Vol. 46, No. 1, pp. 105-115.	11/18/1999 L	
	AQ	Ting-Jen Yeh, et al., "Modeling and Identification of OPTO-Mechanical Coupling and Backlash Monlinearity in Optical Disk Drives," Proceedings of the American Control Conference, Chicago, IL, pp. 3076-3080.	06/2000	

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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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